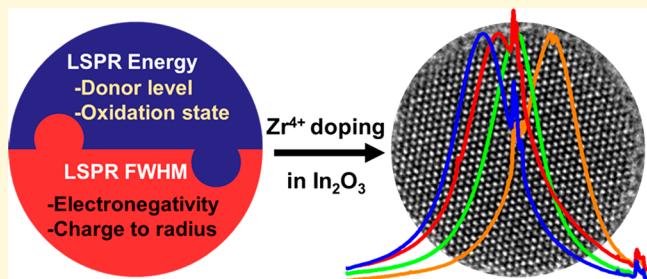


# Dopant Selection Strategy for High-Quality Factor Localized Surface Plasmon Resonance from Doped Metal Oxide Nanocrystals

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## Supporting Information

**ABSTRACT:** Thin films of degenerately doped metal oxides such as those of Sn-doped  $\text{In}_2\text{O}_3$  ( $\text{Sn}:\text{In}_2\text{O}_3$ ) are commercially significant for their broad utilization as transparent conducting electrodes in optoelectronic devices. Over the past decade, nanocrystals (NCs) of  $\text{Sn}:\text{In}_2\text{O}_3$  and other doped metal oxides have also attracted interest for localized surface plasmon resonance (LSPR) that occurs in the near- to mid-infrared region. The suitability of this LSPR for some applications depends on its capacity to concentrate light in small regions of space, known as near-field hot spots. This efficiency to create near-field hot spots can be judged through an LSPR figure-of-merit such as Quality factor (Q-factor), defined as the ratio of LSPR peak energy to its line width. The free electron density determines the LSPR peak energy, while the extent of electron scattering controls the LSPR line width; hence, these factors together essentially dictate the value of the Q-factor. An unfortunate trade-off arises when dopants are introduced since the aliovalent dopants generating the free electrons (increasing LSPR energy) also act as centers of scattering of electrons (increasing LSPR line width), thereby decreasing the LSPR Q-factor. Dopant selection is hence of paramount importance to achieve a high value of LSPR Q-factor. Here, we describe the properties of aliovalent cationic dopants that allow both high LSPR energy and low LSPR line width and, subsequently, high LSPR Q-factor. In this context, we identify  $\text{Zr}^{4+}$  as a model aliovalent dopant for high LSPR Q-factor in the  $\text{In}_2\text{O}_3$  lattice. The resulting  $\text{Zr}$ -doped  $\text{In}_2\text{O}_3$  NCs exhibit one of the highest LSPR Q-factors reported in the mid-infrared region while also performing equivalently to the recognized materials for either high dopant activation ( $\text{Sn}:\text{In}_2\text{O}_3$  NCs) or low LSPR line width ( $\text{Ce}$ -doped  $\text{In}_2\text{O}_3$  NCs) simultaneously. The  $\text{Zr}$  donor level is positioned well inside the conduction band of  $\text{In}_2\text{O}_3$ , and  $\text{Zr}$  doping is surface segregated, both minimizing electron scattering. The combination of this low electron scattering and high dopant activation of  $\text{Zr}^{4+}$  ions is responsible for the high LSPR Q-factors. These strategies can be used to design a variety of doped metal oxide NC systems exhibiting high LSPR Q-factors.



Thin films of degenerately doped metal oxides have been long utilized as transparent conducting electrodes in solar cells and photovoltaics due to their unusual ability to combine the properties of visible light transparency and high electrical conductivity in one material.<sup>1</sup> Owing to the same free electron properties, nanocrystals (NCs) of such degenerately doped metal oxides also exhibit mid- to near-infrared localized surface plasmon resonance (LSPR).<sup>2–7</sup> The LSPR response is induced by the generation of free charge carriers (electrons in case of n-doped metal oxides discussed here), which collectively oscillate at resonant frequencies. These LSPR active NCs may find applications in sensing,<sup>8–10</sup> photothermal therapy,<sup>11</sup> photovoltaics,<sup>12</sup> electrochromic coatings,<sup>13–15</sup> and advanced spectroscopies such as surface-enhanced infrared absorption (SEIRA).<sup>3</sup> For many of these potential applications, the potential of these NCs to create intense localized electric fields (hot spots) around them is essential. In general, LSPR excitations can effectively focus electric fields into volumes well below the diffraction limit, but this is not yet well established for doped metal oxide materials. The potential efficiency of hot

spot generation can be assessed indirectly by a figure of merit derived from the LSPR response known as the Quality factor (or Q-factor), which is defined as the ratio of the LSPR peak energy to its full width at half-maximum (fwhm). LSPR peak energy depends on the free carrier density in the NCs, while the fwhm reflects the extent of carrier scattering, e.g., by charged point defects in the NC lattice.<sup>16</sup> Consequently, a high Q-factor suggests stronger near-field enhancements, longer plasmon lifetimes, and weaker electronic damping. Hence, it becomes important to consider two significant impacts of dopants in metal oxide NCs: (a) changing free electron density leading to tuning of the LSPR energy and (b) scattering the motion of oscillating free electrons leading to damping of the LSPR.

In some cases, the relatively high value of the high-frequency dielectric constant of the host material enables unusually high

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LSPR Q-factors through shielding the electrostatic interactions between the dopants and the electrons. This is generally the case for doped CdO,<sup>17</sup> such as NCs of In-doped CdO,<sup>18</sup> and F, In-codoped CdO.<sup>19</sup> Regardless of the dielectric characteristics of the host material, a high LSPR Q-factor can conceivably be engineered based on the selection of the aliovalent dopant. For instance, Sn<sup>4+</sup> is a shallow donor in In<sub>2</sub>O<sub>3</sub>, donating electrons to the conduction band of In<sub>2</sub>O<sub>3</sub> and increasing the LSPR energy.<sup>20–22</sup> However, apart from acting as ionized donor impurities, Sn dopants in In<sub>2</sub>O<sub>3</sub> also hybridize with In 5s orbitals, leading to significant renormalization of the band curvature at the conduction band minimum,<sup>23–25</sup> thereby changing the effective mass, increasing the LSPR fwhm, and decreasing the electron mobility.<sup>16</sup> Cerium is an alternative dopant for In<sub>2</sub>O<sub>3</sub> or a codopant with Sn that has been reported to minimize ionized impurity scattering. Ce<sup>4+</sup> introduces defect states deep in the conduction band of In<sub>2</sub>O<sub>3</sub>, well away from the conduction band edge, leading to a narrow LSPR fwhm. Unfortunately, Ce<sup>4+</sup> is readily reduced to Ce<sup>3+</sup>, so dopant activation is low, especially at higher dopant concentrations, and the LSPR energy achievable by this strategy is limited.<sup>26</sup> In each case—either Sn and Ce-doped In<sub>2</sub>O<sub>3</sub> NCs—one attribute of the dopant substantially limits the LSPR Q-factor, and yet these materials still exhibit among the highest Q-factor values in the near-infrared. Therefore, there is a potential to enhance LSPR Q-factor further through a combination of high LSPR energy and low LSPR fwhm. Achieving this requires identification of dopants through their fundamental properties which will simultaneously increase LSPR energy and diminish fwhm as dopants interact with the crystal lattice, ultimately leading to high LSPR Q-factors.

The LSPR frequency  $\omega_{\text{LSPR}}$  can be described by eq 1

$$\omega_{\text{LSPR}} = \sqrt{\frac{\omega_p^2}{(\epsilon_{\infty} + 2\epsilon_m)} - \Gamma^2} \quad (1)$$

where  $\epsilon_{\infty}$  is the high-frequency dielectric constant of the material,  $\epsilon_m$  is the dielectric constant of the medium surrounding the NCs, and  $\Gamma$  is the damping constant. Since,  $\epsilon_{\infty}$  is a characteristic property of the material that is not expected to change with doping and  $\epsilon_m$  is fixed by the environment (the solvent in the case of dispersed NCs), the controllable parameters with a strong influence on the LSPR frequency are the damping constant (that determines LSPR fwhm) and the bulk plasma frequency  $\omega_p$ , which is given by

$$\omega_p^2 = \frac{ne^2}{\epsilon_0 m^*} \quad (2)$$

where  $n$  is the free carrier density,  $e$  is the electronic charge,  $\epsilon_0$  is the permittivity of air/vacuum, and  $m^*$  is the effective mass of the free charge carriers (electrons or holes).<sup>27</sup> Since  $e$  and  $\epsilon_0$  are constants, the LSPR energy is directly dependent on the carrier density and the effective carrier mass. In this regard, two scenarios can be envisaged when it comes to generating free charge carrier density by a cationic substitutional doping in metal oxides: (a) when the dopant level exists close to the conduction band minimum (shallow donor) and (b) when the dopant states reside well inside the conduction band of the host. As an example of the first scenario, a shallow donor (such as Sn in In<sub>2</sub>O<sub>3</sub>) hybridizes with the conduction band minimum triggering renormalization of conduction band curvature, and therefore, a flatter band with higher effective carrier mass is obtained.<sup>28</sup> This hybridization leads to a lower  $\omega_p$ , and hence,

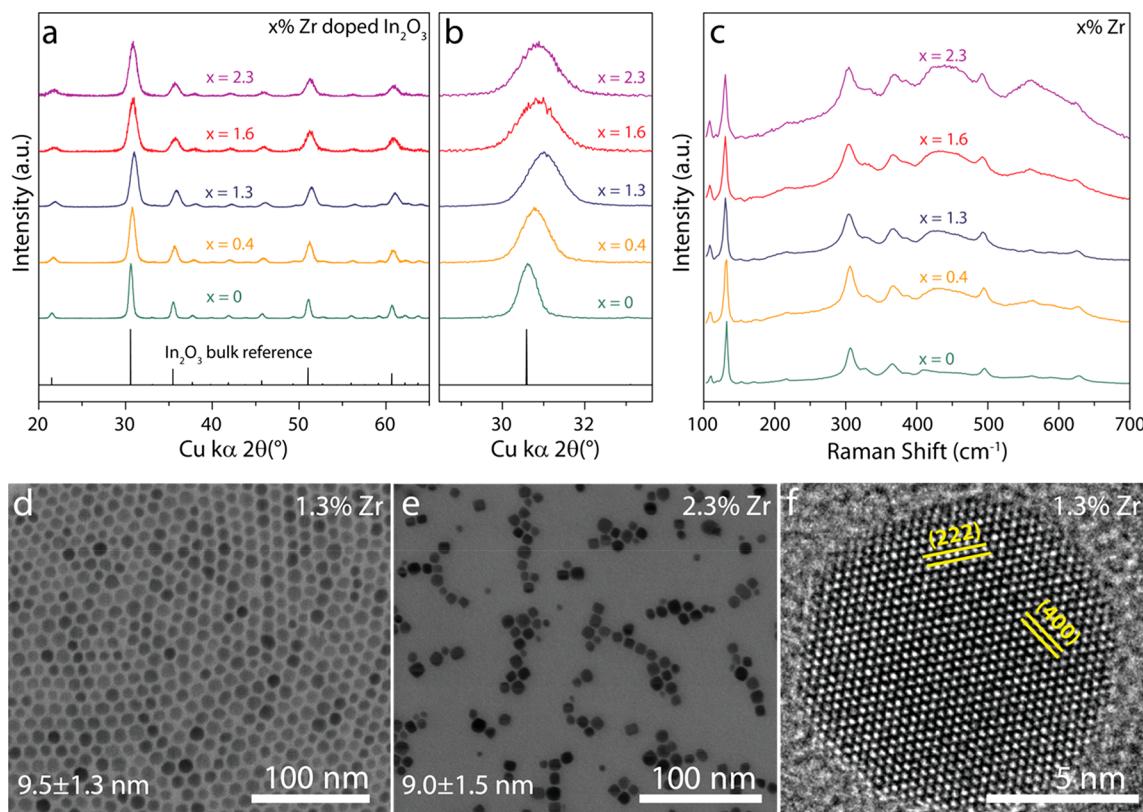
a donor level inside the conduction band is preferred over a shallow donor for generation of free electrons and raising of  $\omega_p$ .<sup>26,28,29</sup> Additionally, generation of free electrons can be hindered if the dopant exhibits multiple stable oxidation states, if electron acceptors are present,<sup>26,30–33</sup> or if defect clusters introduce electron trapping sites.<sup>23,34–36</sup> These compensation effects are highly undesirable as they decrease the dopant activation (number of electrons generated per dopant). One can estimate the feasibility of change in oxidation state through the standard reduction potentials. Metal ions exhibiting multiple oxidation states with large positive values of standard reduction potentials are not likely to perform as ideal dopants for generation of high electron density. For example, the standard reduction potential for reduction of Ce<sup>4+</sup> to Ce<sup>3+</sup> is +1.44 V as a result of which Ce<sup>4+</sup> doping in In<sub>2</sub>O<sub>3</sub> suffers from the problem of low dopant activation.<sup>26</sup>

The damping constant  $\Gamma$  is a reflection of electron scattering though mechanisms typically including electron–electron and electron–phonon scattering, which are not necessarily the dominant electron scattering mechanisms in doped metal oxide NCs. When the size of a NC becomes much smaller than the bulk mean free path of carrier in a material, surface scattering can be significant.<sup>37</sup> In doped metal oxides NCs, at all sizes electrostatic interactions between the dopant ions and the electrons can significantly impact scattering.<sup>16</sup> This phenomenon is known as ionized impurity scattering,<sup>16</sup> and the LSPR fwhm can be limited by the strength of this electrostatic interaction, which can be described by the Lewis acidity of the dopant. According to the quantitative description given by Zhang et al.,<sup>38</sup> the Lewis acidity  $L$  of an ion is expressed as

$$L = \frac{Z}{r^2} - 7.7\chi + 8.0 \quad (3)$$

where  $Z$  is the charge on an ion,  $r$  is the radius of the ion, and  $\chi$  is the electronegativity of the element. A stronger Lewis acid (large  $L$ ) will, therefore, be a better aliovalent dopant than a weaker one. This is because a high charge to radius ratio polarizes the electron cloud of the oxygen more strongly, reducing its capability as a scattering center. On the other hand, a smaller electronegativity value than the host cation ensures that the interactions between the free electrons and the dopant cations are minimized. In terms of electronic band structure, this means that the dopant levels lie higher in energy than the conduction band minimum of the host lattice. Owing to this alignment, Ce, which has a low electronegativity value, leads to a much larger  $L$  value (smaller LSPR fwhm) than Sn<sup>21,26</sup> in In<sub>2</sub>O<sub>3</sub> despite Sn exhibiting a higher charge to radius ratio.<sup>39</sup> However, a very large Lewis acidity can also lead to trapping of charge carriers due to electron-acceptor behavior of Lewis acids. Nonetheless, to obtain a low LSPR fwhm in In<sub>2</sub>O<sub>3</sub> NCs, a dopant with a charge-to-radius ratio greater than In and an electronegativity value smaller than In is desired. However, a large change in charge to radius ratio with respect to the host cation can also produce significant lattice strain in the host lattice and may even induce formation of a secondary phase.

In consideration of the above, Zr<sup>4+</sup> appears to be a compelling candidate as a dopant in In<sub>2</sub>O<sub>3</sub>. Zr is almost always found in the +4 oxidation state (standard reduction potential Zr<sup>4+</sup>/Zr = -1.45 V), which makes it an aliovalent dopant in the In<sub>2</sub>O<sub>3</sub> lattice (Zr<sub>In</sub>). Recent calculations by Xu et al. have shown that donor levels for Zr lie deep inside the conduction band of In<sub>2</sub>O<sub>3</sub> (which can be ascribed largely to its



**Figure 1.** Characterization of Zr:In<sub>2</sub>O<sub>3</sub> NCs: (a) comparison of XRD patterns with bulk In<sub>2</sub>O<sub>3</sub> reference (JCPDS 88-2160) indicating retention of the cubic bixbyite structure across doping concentrations, (b) shift in the XRD peaks with incorporation of Zr<sup>4+</sup> ions, (c) Raman spectroscopy signifying the absence of any impurity phase, amorphous or crystalline, (d and e) STEM images showing nearly spherical NCs with a narrow size distribution, (f) high-resolution TEM image showing the single-crystalline nature of the NCs with interplanar distances corresponding to different planes in the In<sub>2</sub>O<sub>3</sub> structure.

lower electronegativity than In) and proposed it to be a prospective dopant of choice for high-mobility transparent conducting oxides.<sup>28</sup> The occurrence of Zr donor levels deep inside the conduction band means that the curvature of the conduction band minimum is not expected to be affected by doping and electrons donated will have a low carrier effective mass close to the 0.22m<sub>e</sub> of the parent In<sub>2</sub>O<sub>3</sub> material. Moreover, the ionic radius of Zr<sup>4+</sup> (74 pm) matches closely with that of In<sup>3+</sup> (79 pm), signifying that no significant lattice strain is anticipated from the substitution of In with Zr while sustaining a higher charge-to-radius ratio than In.<sup>40</sup> We, therefore, hypothesized that Zr doping in In<sub>2</sub>O<sub>3</sub> NCs could lead to a high Q-factor LSPR with high dopant activation and low fwhm, which would also imply an increased mobility of electrons. Prior experimental reports showing high electron mobilities in Zr-doped In<sub>2</sub>O<sub>3</sub> thin films<sup>41–43</sup> encouraged us to develop a synthesis for Zr-doped In<sub>2</sub>O<sub>3</sub> (Zr:In<sub>2</sub>O<sub>3</sub>) NCs and examine their mettle as an LSPR active material.

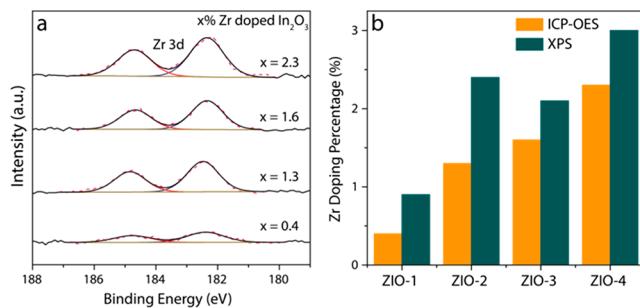
We report here the colloidal synthesis of Zr:In<sub>2</sub>O<sub>3</sub> NCs by a procedure involving alcoholysis of metal carboxylates.<sup>44,45</sup> In brief, using standard Schlenk line techniques operating under inert N<sub>2</sub> atmosphere, 8 mL of 0.5 M mixture of In and Zr precursors, indium(III) acetate and zirconium(IV) acetylacetone, respectively, was dissolved in oleic acid at 150 °C. A mixture of these was injected at a rate of 0.2 mL/min into 13 mL of oleyl alcohol held at 290 °C. After the reaction, the solution was cooled down, and the resultant NCs were washed with ethanol and dispersed in different nonpolar solvents for further characterization. The synthesis and characterization

details are described in sections S1 and S2 of the Supporting Information, respectively. The doping percentages reported herein were obtained using inductively coupled plasma optical emission spectroscopy (ICP-OES).

The structure of the NCs was assessed by X-ray diffraction (XRD, Figure 1a). At all dopant concentrations, the NCs have the same cubic bixbyite structure as the parent In<sub>2</sub>O<sub>3</sub> and no impurity peaks are present. Moreover, as the Zr doping percentage is increased, the diffraction peaks first shift to higher 2θ values (signifying a decrease in the lattice constant) and then shift back to smaller 2θ values, suggesting an interplanar distance similar to undoped In<sub>2</sub>O<sub>3</sub> NCs (Figure 1b). The ionic radius of Zr<sup>4+</sup> is smaller than that of In<sup>3+</sup>,<sup>40</sup> which could be expected to lead to a gradual decrease in the lattice constant with an increase in Zr doping percentage, in accordance with Vegard's law.<sup>46</sup> The observed trend is more complex since the lattice constant increases as doping percentages above 1.5%. However, similar trends have routinely been reported in doped metal oxides and, in particular, in Sn:In<sub>2</sub>O<sub>3</sub>, where the lattice expansion is attributed to the repulsion between the Sn<sup>4+</sup> ions which cannot be compensated entirely by the electron density in the lattice.<sup>22,47,48</sup> We suggest that a similar mechanism is underlying the trend reported here with Zr<sup>4+</sup> ions incorporated in the In<sub>2</sub>O<sub>3</sub> lattice across the range of compositions we synthesized, with competing factors influencing the lattice constant. Our understanding that Zr is well incorporated in the lattice is further substantiated by the systematic increase in the fwhm of the XRD peaks with an increase in Zr doping

signifying a systematic decrease in the crystallite size. We note here that inhomogeneous strain in the NCs can also broaden the XRD peaks, but it is unlikely to follow a systematic trend with Zr doping. We complemented the XRD analysis with Raman spectroscopy to assess the potential formation of any amorphous or impurity phases (Figure 1c). Regardless of Zr dopant concentration, the Zr:In<sub>2</sub>O<sub>3</sub> NCs exhibit the same phonon modes as undoped In<sub>2</sub>O<sub>3</sub> NCs, suggesting that no significant amorphous or crystalline impurity phases are present.<sup>31,49,50</sup> The trend of XRD peak widths suggesting a decrease in NC size with an increase in Zr doping percentage is confirmed by direct observations using scanning transmission electron microscopy (STEM) (Figure 1d, 1e, S1, and S2). The morphology of the NCs vary between spherical to nearly cubic, which is attributed to the varied amounts of water present in the reaction vessel that leads to passivation of {001} facets by hydroxyl groups.<sup>44</sup> The high-resolution TEM images in Figure 1f show the single-crystalline nature of Zr:In<sub>2</sub>O<sub>3</sub> NCs and interplanar distances corresponding to different lattice planes in the cubic bixbyite structure, further confirming the crystalline structure of the synthesized NCs.

To ascertain the oxidation state of the Zr ions in the In<sub>2</sub>O<sub>3</sub> NCs, we employed X-ray photoelectron spectroscopy (XPS) on all of the Zr: In<sub>2</sub>O<sub>3</sub> NCs and plotted the obtained spectra in the Zr 3d region (Figure 2a). Zr 3d<sub>5/2</sub> and Zr 3d<sub>3/2</sub> binding



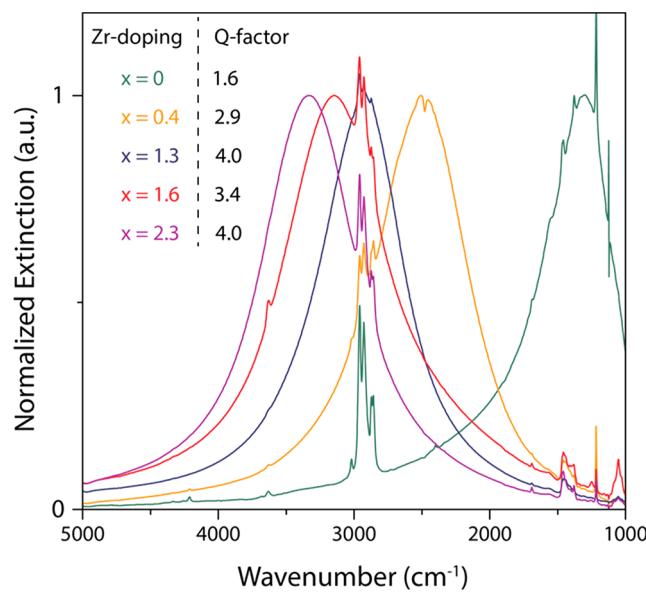
**Figure 2.** Dopant oxidation state and radial distribution: (a) XPS of the Zr 3d region for different Zr:In<sub>2</sub>O<sub>3</sub> NCs with single-component fits (black) to the experimental spectra (pink) shown, (b) comparison of ICP-OES and XPS doping percentages revealing that Zr doping is surface segregated as doping percentages obtained for the surface (XPS) is more than the overall NC composition (ICP-OES). Notations ZIO-1 to ZIO-4 on the x axis just represent NCs with 4 different Zr doping percentages.

energy peaks located at 182.3 and 184.7 eV correspond to Zr in the +4 oxidation state,<sup>51,52</sup> progressively increasing in intensity with an increase in the Zr doping. The spectra could be fit using only one component, which further indicates the presence of Zr in a single oxidation state.

To determine the radial distribution of Zr in the NC, we compared the doping percentages obtained from XPS and ICP-OES. XPS gives an estimation of the surface doping percentage, whereas ICP-OES is a measure of overall NC composition (surface and core). Doping percentages obtained from XPS are significantly greater than those from ICP-OES (Figure 2b), suggesting that Zr is slightly surface segregated; in other words, Zr<sup>4+</sup> ions preferentially substitute at In sites nearer to the surface of the NCs. Although the precise mechanism responsible for surface segregation of Zr dopants could not be elucidated, we hypothesize that using precursors with different reactivity (indium(III) acetate, a highly reactive

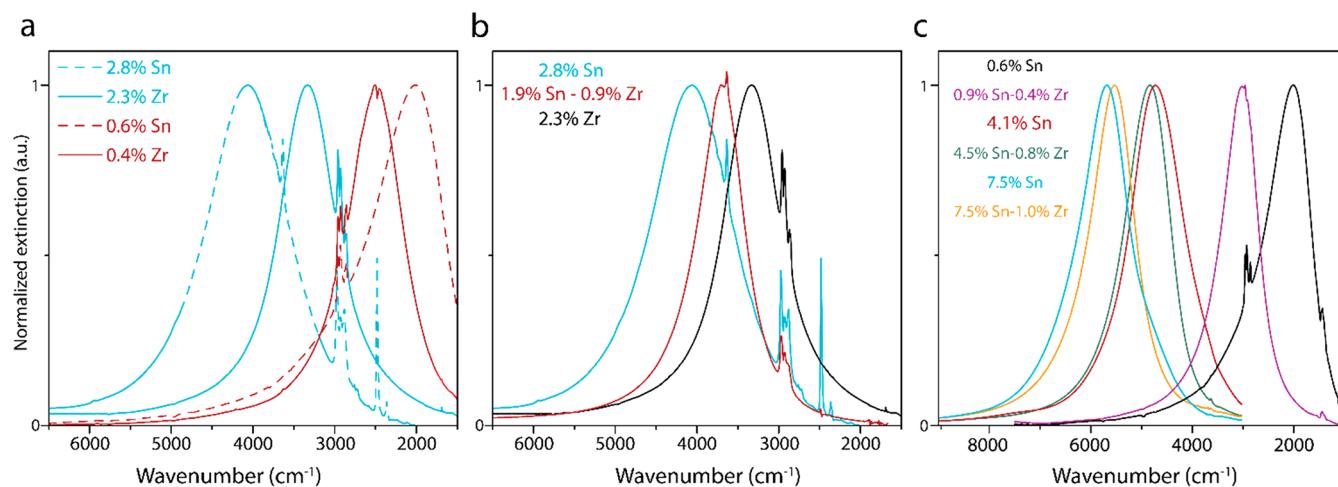
in precursor versus the only moderately reactive Zr precursor, zirconium(IV) acetylacetone) alters the kinetics of incorporation of In and Zr ions during NC growth and ultimately affects the radial distribution of dopants.<sup>53</sup> Surface-segregated doping can be favorable as previous work has shown that it is associated with narrow LSPR and high Q-factors.<sup>21,22,54</sup> Dopants segregated near the surface allow charge carriers to move inside the lightly doped or undoped NC core without scattering from ionized impurities. The reduced scattering significantly minimizes LSPR damping, thereby decreasing the LSPR fwhm and enhancing electron mobility.

All of the Zr:In<sub>2</sub>O<sub>3</sub> NCs show remarkably narrow LSPR absorption with their LSPR energies monotonically increasing with an increase in Zr dopant concentration, signifying the donor behavior of Zr<sup>4+</sup> ions (Figures 3 and S3). The LSPR of



**Figure 3.** Optical extinction spectra of different Zr:In<sub>2</sub>O<sub>3</sub> NCs displaying narrow and symmetric LSPR bands increasing in energy with an increase in Zr doping. Spectra were taken by FTIR of NCs dispersed in tetrachloroethylene.

undoped In<sub>2</sub>O<sub>3</sub> NCs is attributed to the accumulation of electron density due to oxygen vacancies, whereas in Zr:In<sub>2</sub>O<sub>3</sub> NCs, Zr doping is largely responsible for generating the free electrons. The highly symmetric shapes of the LSPR peaks in Figure 3 indicate there is little ionized impurity scattering,<sup>16,21,22,27</sup> consistent with our initial hypothesis. The LSPR parameters of different Zr:In<sub>2</sub>O<sub>3</sub> NCs are listed in Table ST1. Quantitatively, the LSPR fwhm of 735 cm<sup>-1</sup> (91 meV) for 1.3% Zr:In<sub>2</sub>O<sub>3</sub> NCs is very close to that reported for Ce-doped In<sub>2</sub>O<sub>3</sub> NCs (77 meV),<sup>26</sup> In-doped CdO (67 meV),<sup>18</sup> and smaller than the lowest reported LSPR fwhm for Sn:In<sub>2</sub>O<sub>3</sub> (99 meV)<sup>22</sup> and other doped metal oxide NCs (Table ST2); hence, Zr:In<sub>2</sub>O<sub>3</sub> NCs exhibit one of the narrowest LSPR peaks yet reported. In terms of LSPR Q-factor, Zr:In<sub>2</sub>O<sub>3</sub> NCs display rather high values over a range of LSPR energies that are almost identical to those of Ce-doped In<sub>2</sub>O<sub>3</sub> NCs and subsequently one of the highest in the literature. Electron concentrations achievable with Ce doping are limited by the stability of the Ce<sup>3+</sup> ion, which is increasingly preferentially as compared to Ce<sup>4+</sup> at high doping percentages, thereby reducing the dopant activation. Consequently, the LSPR in Ce-doped In<sub>2</sub>O<sub>3</sub> NCs was tunable only over a narrow range at



**Figure 4.** FTIR spectra of doped  $\text{In}_2\text{O}_3$ NCs. Establishing the high dopant activation behavior but better aliovalent nature of  $\text{Zr}^{4+}$  ions over  $\text{Sn}^{4+}$  ions by comparing FTIR spectra in (i) Series-1,  $\text{Zr}:\text{In}_2\text{O}_3$  and  $\text{Sn}:\text{In}_2\text{O}_3$  NCs with similar doping percentage, (ii) Series-2,  $\text{Zr}:\text{In}_2\text{O}_3$ ,  $\text{Sn},\text{Zr}:\text{In}_2\text{O}_3$ , and  $\text{Sn}:\text{In}_2\text{O}_3$  NCs with similar total cation doping percentage, (iii) Series-3,  $\text{Sn},\text{Zr}:\text{In}_2\text{O}_3$  and  $\text{Sn}:\text{In}_2\text{O}_3$  NCs with similar Sn doping percentage, all showing that for the same doping percentage,  $\text{Zr}:\text{In}_2\text{O}_3$  and  $\text{Sn},\text{Zr}:\text{In}_2\text{O}_3$  NCs have similar LSPR energies but higher LSPR Q-factors as compared to  $\text{Sn}:\text{In}_2\text{O}_3$  NCs.

low energy.<sup>26</sup> Therefore,  $\text{Zr}:\text{In}_2\text{O}_3$  NCs are a more tunable option for applications where high LSPR Q-factors are desirable.

In addition to observing low LSPR fwhm and high Q-factors, we investigated dopant activation in  $\text{Zr}:\text{In}_2\text{O}_3$  NCs, which is a measure of the extent of electron density accumulation for a given doping percentage. Dopant activation is generally high in NCs of the prototypical doped metal oxide material  $\text{Sn}:\text{In}_2\text{O}_3$  NCs,<sup>21,22,54</sup> owing to shallow Sn donor levels in proximity to the conduction band minimum of  $\text{In}_2\text{O}_3$ .

To evaluate the efficacy of  $\text{Zr}^{4+}$  as an electron donor, we designed three different comparison series with Sn. Series-1 compares LSPR spectra of  $\text{Zr}:\text{In}_2\text{O}_3$  and  $\text{Sn}:\text{In}_2\text{O}_3$  NCs with similar doping percentages. Series-2 compares LSPR spectra at a fixed doping percentage achieved through (i) only Zr doping, (ii) only Sn doping, and (iii) Zr and Sn codoping. Series-3 measures the effect of small amounts of Zr codoping on LSPR spectra of different  $\text{Sn}:\text{In}_2\text{O}_3$  NCs. The characterization data for these NCs (XRD and STEM images along with size distribution histograms) are given in Figures S4–S6. The optical extinction spectra obtained from these series are plotted in Figure 4, and their respective LSPR parameters are tabulated in Table ST1.

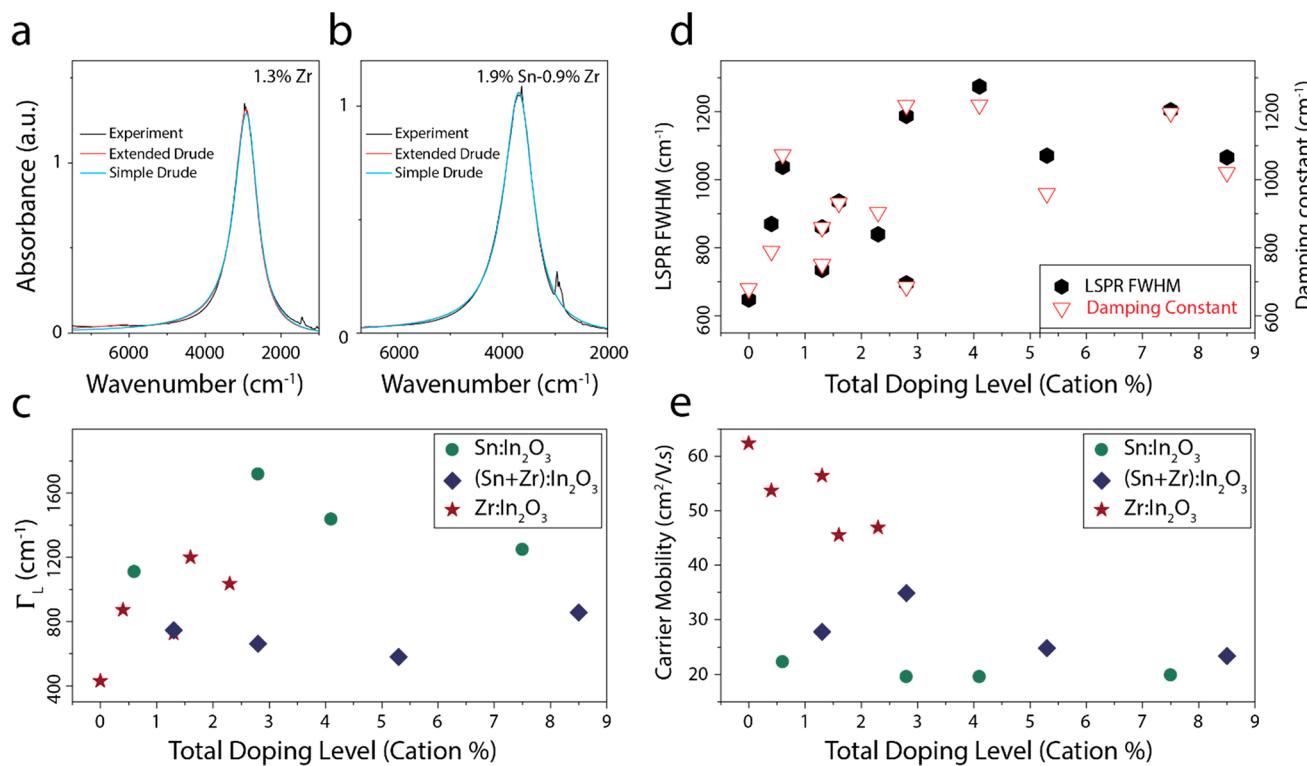
Series-1 compares optical extinction spectra of  $\text{Zr}:\text{In}_2\text{O}_3$  NCs and  $\text{Sn}:\text{In}_2\text{O}_3$  NCs at two different doping percentages, small (~0.5%) and intermediate (~2.5%) (Figure 4a).  $\text{Zr}:\text{In}_2\text{O}_3$  NCs have a higher peak LSPR energy than  $\text{Sn}:\text{In}_2\text{O}_3$  NCs at small doping percentage. However, at intermediate doping percentage, the  $\text{Sn}:\text{In}_2\text{O}_3$  NCs have a higher LSPR energy than  $\text{Zr}:\text{In}_2\text{O}_3$  NCs, potentially due to the difference in the doping level in those two samples and the smaller size of  $\text{Zr}:\text{In}_2\text{O}_3$  NCs as compared to  $\text{Sn}:\text{In}_2\text{O}_3$  NCs, which can decrease dopant activation.<sup>22</sup> Nonetheless, for both doping levels, the LSPR energies for Zr and Sn are in the same range, indicating that both of them have similar donor efficiency. The difference, however, lies in the shape and fwhm of the LSPR. For similar doping percentages, the LSPR of  $\text{Zr}:\text{In}_2\text{O}_3$  NCs is highly symmetric compared to the asymmetric peaks of  $\text{Sn}:\text{In}_2\text{O}_3$  NCs. Additionally, the LSPR fwhm of the  $\text{Zr}:\text{In}_2\text{O}_3$  NCs is at least 20% narrower than that

of  $\text{Sn}:\text{In}_2\text{O}_3$  NCs (Table ST1), which is reflected in the significantly higher LSPR Q-factors of  $\text{Zr}:\text{In}_2\text{O}_3$  NCs than  $\text{Sn}:\text{In}_2\text{O}_3$  NCs. Unfortunately, we could not achieve higher doping concentration with Zr doping because of the low solubility limit of Zr in  $\text{In}_2\text{O}_3$ .<sup>43</sup> NCs are sometimes able to surpass the bulk solubility limit, but even after repeated trials using different Zr and In precursors, we were in this case not successful at increasing the doping concentration further.<sup>55</sup>

Series-2 compared NCs with similar overall doping percentage (~2.5%) but different dopant composition: (i) 2.3% Zr doping, (ii) 2.8% Sn doping, or (iii) 1.9% Sn–0.9% Zr codoping in  $\text{In}_2\text{O}_3$  NCs. The purpose was to assess how the LSPR Q-factor depends on the nature of the dopants. The LSPR energies are almost equivalent for the various dopant combinations, but the LSPR fwhm of  $\text{Zr}:\text{In}_2\text{O}_3$  and  $\text{Sn},\text{Zr}:\text{In}_2\text{O}_3$  NCs is much smaller than that observed for  $\text{Sn}:\text{In}_2\text{O}_3$  NCs (Figure 4b). In fact, as listed in Table ST1, the LSPR fwhm of 1.9% Sn–0.9% Zr-codoped  $\text{In}_2\text{O}_3$  NCs is almost one-half of that of 2.8% Sn:In<sub>2</sub>O<sub>3</sub> NCs. Consequently, there is a 50% enhancement in the LSPR Q-factor for the former compared to the latter. The Q-factor of 5.3 for 1.9% Sn–0.9% Zr-codoped  $\text{In}_2\text{O}_3$  NCs is the highest Q-factor reported in the mid-infrared region and rivals the Q-factors of even the best-performing materials in the near-infrared LSPR literature (Table ST2). Both Series-1 and Series-2 are thus strong indicators of the advantages of Zr over Sn as a dopant in the  $\text{In}_2\text{O}_3$  NC lattice.

To check the efficiency of  $\text{Zr}^{4+}$  in reducing electron scattering from ionized impurities, we made Series-3, where a small amount of Zr (0.5–1.0%) was codoped with small (~1%), intermediate (~5%), and high (~8%) Sn doping percentages to form  $\text{Sn},\text{Zr}:\text{In}_2\text{O}_3$  NCs and compared these with  $\text{Sn}:\text{In}_2\text{O}_3$  NCs having roughly the same Sn doping percentage. Since  $\text{Zr}^{4+}$  is an aliovalent donor, doping in small amounts is expected to shift the LSPR energy, but if it contributes to ionized impurity scattering, it would also induce an increased line width (fwhm) of the LSPR band.

We observe that Zr codoping in  $\text{Sn}:\text{In}_2\text{O}_3$  NCs leads to an increase in the LSPR energy (as compared to  $\text{Sn}:\text{In}_2\text{O}_3$  NCs with the same Sn doping percentage) for both low and



**Figure 5.** Fitting of the optical extinction spectra using the simple and extended Drude models. (a and b) Representative Drude model fits to the LSPR spectra of 1.3% Zr-doped and 0.9% Sn–0.4% Zr-codoped  $\text{In}_2\text{O}_3$  NCs showing excellent fitting. (c) Comparison of the low-frequency damping constants obtained from extended Drude model fits for different NCs indicating much smaller values of  $\Gamma_L$  and hence low electron scattering for  $\text{Zr}:\text{In}_2\text{O}_3$  and  $\text{Sn},\text{Zr}:\text{In}_2\text{O}_3$  NCs than for  $\text{Sn}:\text{In}_2\text{O}_3$  NCs. (d) Correlation between damping constant obtained from simple Drude model fits and experimental LSPR fwhm signifying frequency independence of electron scattering in almost all NCs. (e) Comparison of optical electron mobilities obtained from the simple Drude model shows 3 times enhancement by changing the dopant from  $\text{Sn}^{4+}$  to  $\text{Zr}^{4+}$  due to reduced electron scattering.

intermediate Sn doping percentages. For high Sn doping concentration, however, codoping Zr with Sn leads to a decrease in the LSPR energy. Zr codoping in  $\text{Sn}:\text{In}_2\text{O}_3$  leads to a decrease in the size of the NCs (increase in surface to volume ratio), which places more Sn ions close to the surface than in the core for a constant doping percentage. Since surface Sn dopants have been found to be less activated than the core Sn dopants, a decrease in NC diameter brings down the overall activation of Sn dopants, leading to smaller LSPR energies.<sup>16,22</sup> Zr codoping in  $\text{Sn}:\text{In}_2\text{O}_3$  NCs also decreases the LSPR fwhm and induces a highly symmetric line shape to the LSPR band. This observation, which is constant across all  $\text{Sn},\text{Zr}:\text{In}_2\text{O}_3$  NCs, is also reiterated by the LSPR parameters (Table ST1), where  $\text{Sn},\text{Zr}:\text{In}_2\text{O}_3$  NCs are found to display LSPR fwhm approximately 20% smaller than their  $\text{Sn}:\text{In}_2\text{O}_3$  NCs counterparts. Correspondingly, a 20% enhancement in the LSPR Q-factor is seen despite a decrease in LSPR energy for the 1.0% Zr–7.5% Sn-codoped  $\text{In}_2\text{O}_3$  NCs. Since the degree of surface segregation of the Sn dopants is similar between  $\text{Sn}:\text{In}_2\text{O}_3$  NCs and  $\text{Sn},\text{Zr}:\text{In}_2\text{O}_3$  NCs, we do not consider changes in dopant radial distribution as a potential contributor to the decrease in the LSPR fwhm (Figure S7 and S8). Therefore, Zr doping in  $\text{In}_2\text{O}_3$  can be associated with high Q-factors, and 1.0% Zr–7.5% Sn-codoped  $\text{In}_2\text{O}_3$  NCs exhibit an LSPR Q-factor of 5.3 (identical to 0.9% Zr–1.9% Sn), among the highest in the literature (Table ST2). Hence, the three series give conclusive evidence that Zr doping in  $\text{In}_2\text{O}_3$  NCs leads to a combination of high dopant activation, narrow LSPR line width, and high Q-factor.

For a further quantitative interpretation we modeled the LSPR response of all of our NCs with the simple Drude and the extended Drude models by employing a MATLAB code. Since the optical properties of a material are governed by its complex dielectric function, both the carrier density and the damping of charge carriers can be accounted for by considering the free carrier contribution to the complex dielectric function.<sup>16,27</sup> For noble metals, this is given by the simple Drude model which can be represented as

$$\epsilon_D = \epsilon_\infty - \frac{\omega_p^2}{\omega^2 + i\omega\Gamma} \quad (4)$$

where  $\omega_p$  is the bulk plasma frequency defined in eq 2,  $\epsilon_\infty$  is the high-frequency dielectric constant,  $\Gamma$  is the damping constant, and  $\omega$  is the angular frequency of the incoming electromagnetic radiation. However, this simple Drude model does not take into account the contribution of ionized impurity scattering, which is a major scattering mechanism in doped semiconductors. For this purpose, in doped semiconductor systems we often use the extended Drude model where the frequency-independent damping constant  $\Gamma$  in the simple Drude is replaced by a frequency-dependent analogue  $\Gamma(\omega)$  symbolized through the empirical equation<sup>16</sup>

$$\Gamma(\omega) = \Gamma_L - \frac{\Gamma_L - \Gamma_H}{\pi} \left[ \tan^{-1} \left( \frac{\omega - \Gamma_X}{\Gamma_W} \right) + \frac{\pi}{2} \right] \quad (5)$$

where  $\Gamma_L$  and  $\Gamma_H$  are the low-frequency and high-frequency damping constants, respectively,  $\Gamma_X$  is the crossover-frequency from the low- to the high-frequency region, and  $\Gamma_W$  is the width of the crossover region. The value of  $\Gamma_L$  qualitatively signifies the extent of scattering by ionized dopants, and therefore, to achieve a low LSPR fwhm and symmetric LSPR band,  $\Gamma_L$  should be minimized. Since the extent of carrier scattering is determined by the damping constants, carrier mobilities can also be derived optically from the damping function using

$$\mu_{\text{opt}} = \frac{e}{m^* \Gamma(0)} \quad (6)$$

where we assume that the electrostatic potential at low frequencies would be equivalent to the carriers moving under the influence of a dc electric field, and therefore, we employ  $\Gamma(0)$ , which is the value of the damping function at zero frequency.<sup>21</sup>

Using the methodology described in section S3, we fitted the optical extinction spectra of all NCs with both the simple and the extended Drude models and extracted the values of the bulk plasma frequency, electron density, damping constants, and optical electron mobilities. Representative plots for both  $\text{Zr:In}_2\text{O}_3$  and  $\text{Sn,Zr:In}_2\text{O}_3$  NCs are shown in Figure 5a and 5b, respectively, and fitting parameters are tabulated for simple Drude and extended Drude models in Tables ST3 and ST4, respectively. The residual fits are presented in Figure S9. Excellent fits could be achieved for all of the Zr-doped NCs for both the simple Drude and the extended Drude models, suggesting that only the free electron density is responsible for the optical absorption.

Discussing the fit parameters for the extended Drude model first, almost all  $\text{Zr:In}_2\text{O}_3$  and  $\text{Sn,Zr:In}_2\text{O}_3$  NCs have a small  $\Gamma_L$  (and  $\Gamma_L \ll \Gamma_H$ ), crossover frequency  $\Gamma_X$  at energies much higher than the LSPR peak position, and narrow crossover width ( $\Gamma_W$ ). These observations are strong indications that there is minimized impurity scattering in both  $\text{Zr:In}_2\text{O}_3$  and  $\text{Sn,Zr:In}_2\text{O}_3$  NCs and electron scattering in these NCs is largely frequency independent. In contrast,  $\text{Sn:In}_2\text{O}_3$  NCs with similar doping concentration are found to have  $\Gamma_L \gg \Gamma_H$ , small crossover frequencies, and large crossover widths. This indicates that ionized impurity scattering is still prominent in these NCs, which contributes to broadened LSPR line widths. Regardless of this, both 4.1% and 7.5%  $\text{Sn:In}_2\text{O}_3$  NCs display appreciably high LSPR Q-factors, which can be attributed in part to the observed slight surface segregation of Sn at high doping percentages that has been found to decrease the electrostatic interactions between the electrons and the ionized dopants and also to their large size, which decreases surface scattering. However, the overall trend that  $\text{Zr:In}_2\text{O}_3$  and  $\text{Sn,Zr:In}_2\text{O}_3$  NCs exhibit much smaller  $\Gamma_L$  than  $\text{Sn:In}_2\text{O}_3$  NCs (which leads to high LSPR Q-factors) with the same doping percentage is robust, as evident by Figure 5c. The smallest  $\Gamma_L$  is exhibited by undoped  $\text{In}_2\text{O}_3$  NCs, which is understandable because electrons therein are only scattered by the oxygen vacancies unlike doped  $\text{In}_2\text{O}_3$  NCs where aliovalent dopants act as majority scattering centers with additional contribution from oxygen vacancies. Furthermore, comparing the electron density obtained from the extended Drude (Table ST3) fittings reveals that Sn and Zr have similar electron density for the same doping percentage, which is in agreement with our initial hypothesis and the results obtained from Series 1–3. A direct consequence of the low  $\Gamma_L$  is reflected in the high

mobility values obtained for  $\text{Sn,Zr:In}_2\text{O}_3$  and  $\text{Zr:In}_2\text{O}_3$  NCs (Table ST3). However, since electron scattering in our NCs seems to be operating through a frequency-independent mechanism, we will instead use parameters derived by fitting to the simple Drude model, which has fewer fit parameters and minimizes uncertainty, to draw additional conclusions about the electronic properties. Moreover, the optical spectra of some NCs have a contribution from the C–H vibrational stretch absorption of the ligands around  $3000\text{ cm}^{-1}$ , which complicates quantitative fitting of the LSPR; this overlapping signal can lead to unreasonably large variations in the value of the parameters in some cases, which is less of a challenge if the fit is constrained with fewer free parameters.

Nonetheless, as described before, excellent fits could be achieved by modeling the absorption spectra through the simple Drude model signifying that the electron scattering mechanism in  $\text{Zr:In}_2\text{O}_3$  and  $\text{Sn,Zr:In}_2\text{O}_3$  NCs is largely frequency independent, similar to that of noble metal NCs. The estimated values of bulk plasma frequency and electron density (Table ST4) are roughly equivalent to those determined from the extended Drude model. From Table ST4 one can observe that the damping constants for both  $\text{Zr:In}_2\text{O}_3$  and  $\text{Sn,Zr:In}_2\text{O}_3$  NCs are very close to that of the undoped  $\text{In}_2\text{O}_3$  NCs and significantly smaller than those of the  $\text{Sn:In}_2\text{O}_3$  NCs, which reiterates our claims of minimized ionized impurity scattering in  $\text{Zr:In}_2\text{O}_3$  and  $\text{Sn,Zr:In}_2\text{O}_3$  NCs. A perfect correlation was observed between the damping constants and the experimental LSPR fwhm for almost all of the NCs, as shown in Figure 5d. This signifies that the simple Drude model is a good representation of the LSPR, and frequency-dependent damping is not needed to describe the dominant electron scattering processes in our NCs, especially  $\text{Zr:In}_2\text{O}_3$  and  $\text{Sn,Zr:In}_2\text{O}_3$  NCs. Using the single damping constant in eq 6, we determined the electron mobilities of different NCs and plotted them in Figure 5e. The electron mobilities of  $\text{Zr:In}_2\text{O}_3$  NCs are almost 3 times greater than that of  $\text{Sn:In}_2\text{O}_3$  NCs and lie very close to that of the undoped  $\text{In}_2\text{O}_3$  NCs. Even the  $\text{Sn,Zr:In}_2\text{O}_3$  NCs exhibit electron mobilities 30–80% greater than  $\text{Sn:In}_2\text{O}_3$  NCs and close to those reported for Ce-doped  $\text{In}_2\text{O}_3$  NCs. For the electron mobility calculations the effective carrier mass for  $\text{Sn:In}_2\text{O}_3$  and  $\text{Sn,Zr:In}_2\text{O}_3$  NCs was approximated as  $0.39m_e$ , whereas that for  $\text{Zr:In}_2\text{O}_3$  NCs was  $0.22m_e$  as suggested by Xu et al.<sup>28</sup> Even if the same effective carrier mass is assumed, the electron mobilities in  $\text{Zr:In}_2\text{O}_3$  NCs would be equivalent if not greater than that of Ce-doped  $\text{In}_2\text{O}_3$  NCs.<sup>26</sup> We attribute this extraordinary electronic quality of  $\text{Zr:In}_2\text{O}_3$  NCs to the optimized position of the Zr defect level in the electronic band structure of  $\text{In}_2\text{O}_3$  coupled with surface-segregated Zr doping, which ensures that the electrostatic potentials experienced by the electrons do not change significantly through the lattice of  $\text{In}_2\text{O}_3$  (see Figure S10 for schematic description). These effects combine to produce a rare combination of high LSPR Q-factor, high dopant activation, and low levels of electron scattering, implying high electron mobilities, all in one material.

In conclusion, we describe the salient properties of an aliovalent dopant that determines its merit in generating high LSPR Q-factor in doped metal oxide NCs. For high LSPR energy, a donor state deep in the conduction band of the host and a stable oxidation state is required, whereas a small LSPR fwhm demands a higher charge to radius ratio and lower electronegativity of the dopant cation with respect to the host

cation. Using these selection criteria, we propose  $Zr^{4+}$  as an ideal aliovalent dopant in the  $In_2O_3$  lattice and report the synthesis of Zr-doped  $In_2O_3$  NCs for the first time. The resulting  $Zr:In_2O_3$  NCs exhibit a rare combination of high dopant activation and low LSPR fwhm, leading to one of the highest Q-factors in the literature on plasmonic nanomaterials. We further prove that our  $Zr:In_2O_3$  NCs are comparable to the best materials for dopant activation (Sn-doped  $In_2O_3$  NCs) and LSPR fwhm (Ce-doped  $In_2O_3$  NCs) simultaneously. Drude fittings of the optical spectra reveal that the electron mobilities in our  $Zr:In_2O_3$  NCs are 3 times as that of  $Sn:In_2O_3$  NCs and equivalent to undoped  $In_2O_3$  NCs, indicating that ionized impurity scattering is essentially absent in our  $Zr:In_2O_3$  NCs. We conclude that the optimized placement of Zr donor levels in the conduction band of  $In_2O_3$  and surface-segregated doping of Zr are responsible for the enhanced electron mobilities and could very much enable  $Zr:In_2O_3$  NCs and films based on these as benchmark materials for applications such as transparent conducting electrodes to be used in flat panel displays and thin film photovoltaics. Since a high Q-factor also facilitates enhanced plasmonic hot spot generation and near-field enhancement, we are confident that  $Zr:In_2O_3$  NCs would be an excellent system for applications like SEIRA and plasmonic sensing. Advancements in the colloidal synthesis of  $Zr:In_2O_3$  NCs will permit one to achieve higher levels of Zr incorporation in the  $In_2O_3$  lattice and one would, therefore, be able to achieve high LSPR Q-factor through the entire near- to mid-infrared range. The approach for this rational dopant selection can ideally be applied to any other metal oxide system like  $TiO_2$ ,  $ZnO$ , and  $SnO_2$ , and additional research in this direction could allow realization of advantageous properties from a broad range of host compositions. A first glimpse of the extendibility of this strategy can be seen in Figure S11, where  $Hf^{4+}$  doping in  $In_2O_3$  (the chemical properties of Hf are very similar to Zr due to lanthanide contraction) also leads to a narrow LSPR in the mid-infrared range.

## ■ ASSOCIATED CONTENT

### Supporting Information

The Supporting Information is available free of charge on the ACS Publications website at DOI: [10.1021/acs.chemmater.9b02917](https://doi.org/10.1021/acs.chemmater.9b02917).

Details of nanocrystal characterization (STEM, XPS, XRD) and Drude modeling scheme along with the fits to the optical extinction spectra and parameters obtained ([PDF](#))

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### Notes

The authors declare no competing financial interest.

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